



BSI Standards Publication

**Microbeam analysis — Analytical electron
microscopy — Method for the determination
of interface position in the cross-sectional
image of the layered materials**

National foreword

This British Standard is the UK implementation of ISO 20263:2024. It supersedes BS ISO 20263:2017, which is withdrawn.

The UK participation in its preparation was entrusted to Technical Committee CII/9, Microbeam analysis.

A list of organizations represented on this committee can be obtained on request to its committee manager.

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